June 1999

FDS6982

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Dual N-Channel, Notebook Power Supply MOSFET

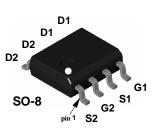
General Description

This part is designed to replace two single SO-8 MOSFETs in synchronous DC:DC power supplies that provide the various peripheral voltage rails required in notebook computers and other battery powered electronic devices. FDS6982 contains two unique 30V, N-channel, logic level, PowerTrench® MOSFETs designed to maximize power conversion efficiency.

The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the low-side switch (Q2) is optimized for low conduction losses (less than $20m\Omega$ at V_{GS} = 4.5V).

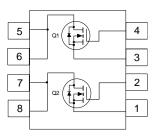
Applications

- Battery powered synchronous DC:DC converters.
- Embedded DC:DC conversion.



Features

- Q2: 8.6A, 30V. $R_{DS(on)} = 0.015 \ \Omega \ @ V_{GS} = 10V$ $R_{DS(on)} = 0.020 \ \Omega \ @ V_{GS} = 4.5V$
- Q1: 6.3A, 30V. $R_{DS(on)} = 0.028 \ \Omega \ @ V_{GS} = 10V$ $R_{DS(on)} = 0.035 \ \Omega \ @ V_{GS} = 4.5V$
- Fast switching speed.
- High performance trench technology for extremely low R_{DS(ON)}.



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Q2	Q1	Units
V _{DSS}	Drain-Source Voltage		30	30	V
V _{GSS}	Gate-Source Voltage		<u>+</u> 20	<u>+</u> 20	V
I _D	Drain Current - Continuous	(Note 1a)	8.6	6.3	Α
	- Pulsed		30	20	
PD	Power Dissipation for Dual Operation		2	W	
	Power Dissipation for Single Operation	(Note 1a)	1.	6	
		(Note 1b)	1		
		(Note 1c)	0.	9	
T _J , T _{stg}	Operating and Storage Junction Temperat	ure Range	-55 to	+150	∘C

Thermal Characteristics

R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	∘C/W
R _θ JC	Thermal Resistance, Junction-to-Case	(Note 1)	40	∘C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
FDS6982	FDS6982	13"	12mm	2500 units

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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Мах	Units
Off Cha	racteristics						-
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I _D = 250 µA	Q2 Q1	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25° C	Q2 Q1		27 26		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	All			1	μA
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V	All			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -20 V, V _{DS} = 0 V	All			-100	nA
V _{GS(th)}	racteristics (Note 2) Gate Threshold Voltage	$V_{DS}=V_{GS},I_{D}=250\;\mu\text{A}$	Q2 Q1	1 1	2.2 1.6	3 3	V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$ $I_D = 250 \ \mu A$, Referenced to $25^{\circ}C$				-	v mV/°(
ΔT_J	Temperature Coefficient		Q1		-4		,
R _{DS(on)}	Static Drain-Source On-Resistance		Q2		0.012 0.018 0.016	0.015 0.024 0.020	Ω
			Q1		0.021 0.038 0.028	0.028 0.047 0.035	Ω
I _{D(on)}	On-State Drain Current	V_{GS} = 10 V, V_{DS} = 5 V	Q2 Q1	30 20			A
g fs	Forward Transconductance	V _{DS} = 5 V, I _D = 8.6 A V _{DS} = 5 V, I _D = 6.3 A	Q2 Q1		50 40		S
Dynami	c Characteristics						
Ciss	Input Capacitance	V _{DS} = 10 V, V _{GS} = 0 V, f = 1.0 MHz	Q2 Q1		2085 760		pF
C _{oss}	Output Capacitance		Q2 Q1		420 160		pF
C _{rss}	Reverse Transfer Capacitance		Q2 Q1		160 70		pF

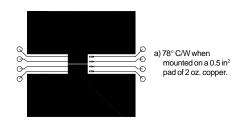
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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Switchir	ng Characteristics (Note	2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A},$	Q2		15	27	ns
	-	$V_{GS} = 10V, R_{GEN} = 6 \Omega$	Q1		10	18	
t _r	Turn-On Rise Time		Q2		11	20	ns
			Q1		14	25	
t _{d(off)}	Turn-Off Delay Time		Q2		36	58	ns
	-		Q1		21	34	
t _f	Turn-Off Fall Time		Q2		18	29	ns
			Q1		7	14	
Qq	Total Gate Charge	Q2	Q2		18.5	26	nC
5		$V_{DS} = 15 \text{ V}, I_{D} = 8.6 \text{ A}, V_{GS} = 5 \text{ V}$	Q1		8.5	12	
Q _{gs}	Gate-Source Charge		Q2		7.3		nC
5-		Q1	Q1		2.4		
Q _{qd}	Gate-Drain Charge	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}, \text{V}_{GS} = 5 \text{ V}$	Q2		6.2		nC
3-	_		Q1		3.1		
Drain-So	<u>purce Diode Characteri</u>	stics and Maximum Ratings	5				
ls	Maximum Continuous Drain-S	Source Diode Forward Current	Q2			1.3	Α
			Q1			1.3	
V _{SD}	Drain-Source Diode Forward	$V_{GS} = 0 \text{ V}, I_{S} = 1.3 \text{ A}$ (Note 2)	Q2		0.72	1.2	V
	Voltage	$V_{GS} = 0 V, I_S = 1.3 A$ (Note 2)	Q1		0.74	1.2	1

Notes:

 R_{eJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{eJC} is guaranteed by design while R_{eCA} is determined by the user's board design. Thermal rating based on independant single device opperation.



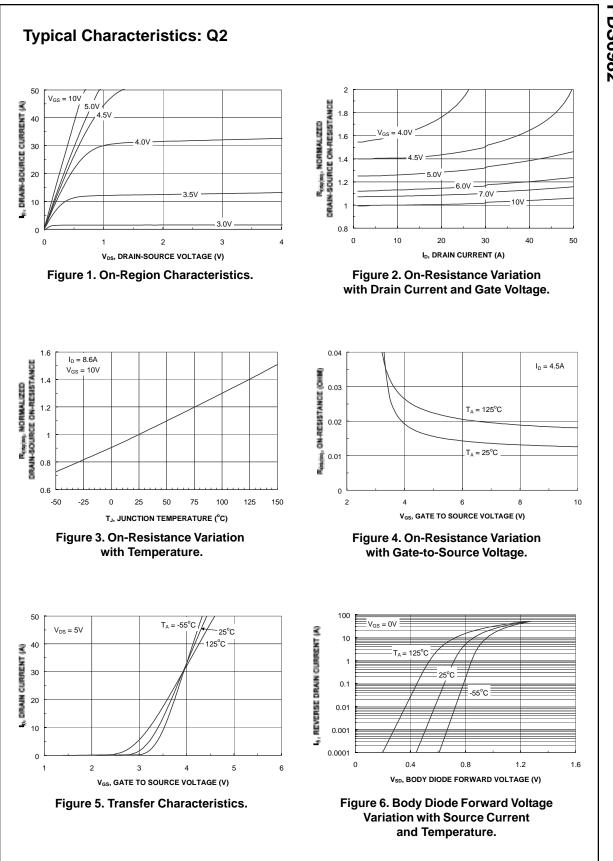


b) 125° C/W when mounted on a 0.02 in² pad of 2 oz. copper.

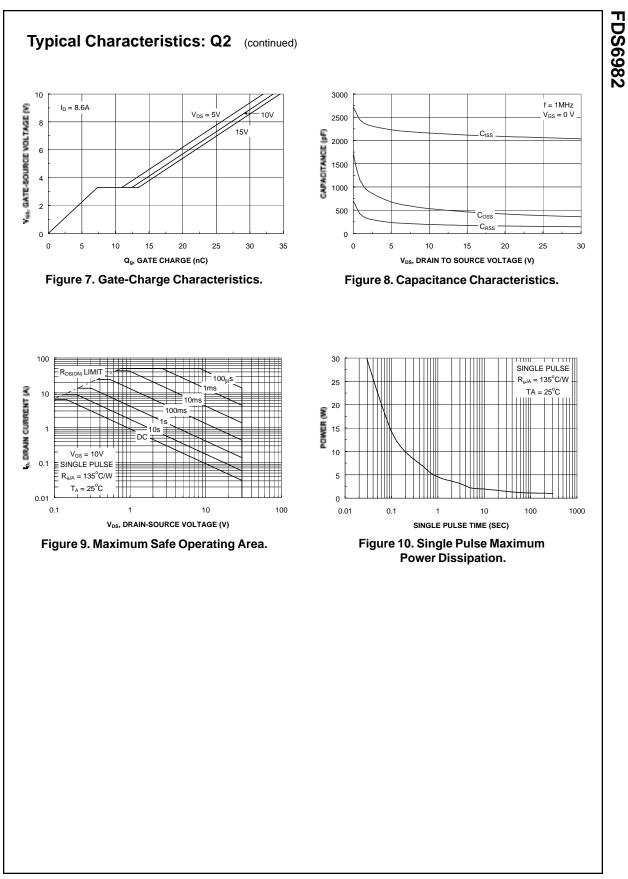
c) 135° C/W when mounted on a minimum pad.

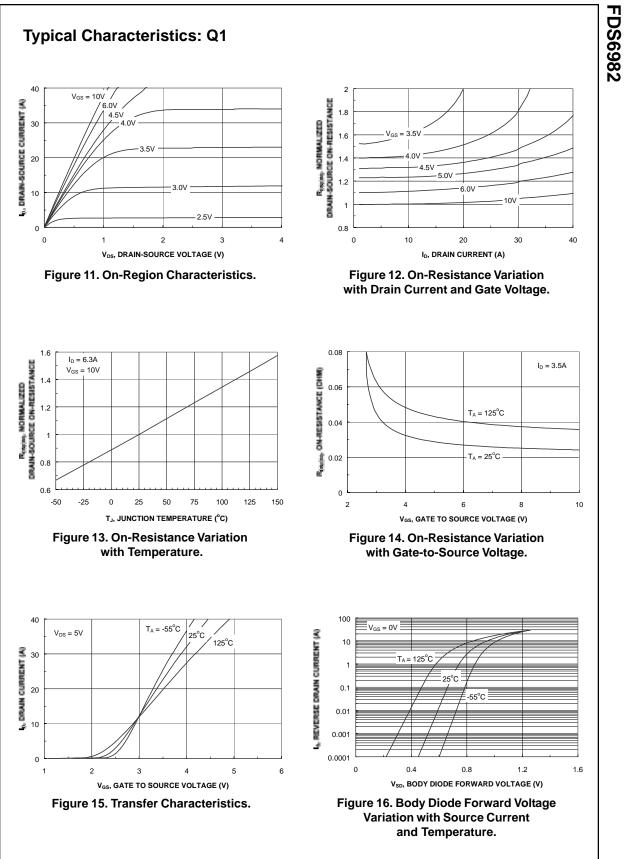
Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

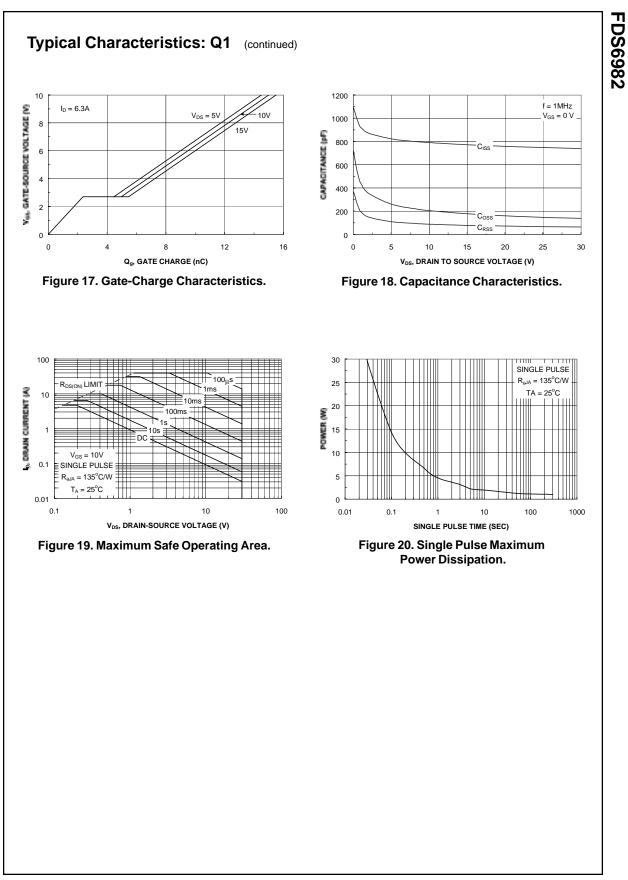


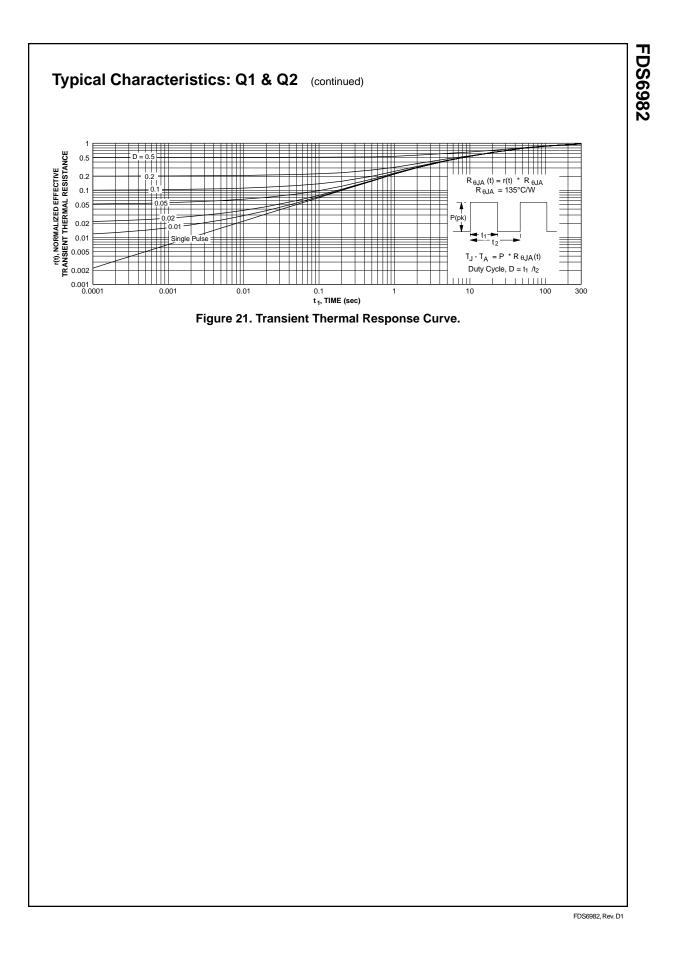
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